

**Notice of References Cited**

Application/Control No.

09/391,052

Applicant(s)/Patent Under  
Reexamination  
NAOI, YUICHI

Examiner

Madeleine AV Nguyen

Art Unit

2622

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,596,628	01-1997	Klein	379/93
	B	US-5,608,546	03-1997	Nakamura et al	358/468
	C	US-5,974,559	10-1999	Bannai	713/330
	D	US-6,098,175	08-2000	Lee	713/320
	E	US-6,160,873	12-2000	Truong et al	379/102.02
	F	US-5,822,597	10-1998	Kawano et al	395/750.05
	G	US-5,794,058	08-1998	Resnick	395/750.05
	H	US-6,089,456	07-2000	Walsh et al	235/472.01
	I	US-5,428,790	06-1995	Harper et al	395/750
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.